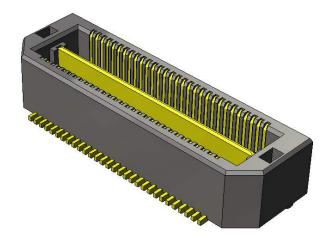


CCURRENT CONTRACTOR CO

QSH Series – Socket, Vertical Orientation

QTH Series – Terminal, Vertical Orientation



Other configurations available for:

Co-planar and perpendicular board-to-board applications

Rugged features / end options

Packaging options

See <u>www.samtec.com</u> for more information.



1.0 SCOPE

1.1 This specification covers performance, testing and quality requirements for Samtec QSH/QTH Series 0,50 mm (.0197") Q Strip[®] High Speed Ground Plane Socket/Terminal Strip connector system. These socket and terminal strips are available in Vertical, Edge Mount and Right Angle configurations for parallel, perpendicular and coplanar board-to-board applications. All information contained in this specification is for a 5 mm mated height vertical configuration unless otherwise noted.

2.0 DETAILED INFORMATION

2.1 Product prints, footprints, catalog pages, test reports and other specific, detailed information can be found at <u>www.samtec.com?QSH</u> and <u>www.samtec.com?QTH</u>.

3.0 TESTING

- 3.1 Current Rating: Signal: 2A (One Pin Powered Per Row)
- **3.2 Voltage Rating:** 175 VAC
- 3.3 Operating Temperature Range: -55°C to +125°C
- 3.4 Operating Humidity Range: 90% to 95% (Per EIA-364-31)
- 3.5 Electrical:

ITEM	TEST CONDITION	REQUIREMENT	STATUS
Withstanding Voltage	EIA-364-20 (No Flashover, Sparkover, or Breakdown)	525 VAC	Pass
Insulation Resistance	EIA-364-21 (1000 MΩ minimum)	5,000 ΜΩ	Pass
Contact Resistance (LLCR)	EIA-364-23	Δ 15 m Ω maximum (Samtec defined)/ No damage	Pass

3.6 Mechanical:

ITEM	TEST CONDITION	TEST CONDITION REQUIREMENT	
Durability	EIA-364-09C	100 cycles (10µ" Au)	
Random Vibration	EIA-364-28 Condition V, Letter B 7.56 G 'RMS', 50 to 2000 Hz, 2 hours per axis, 3 axis total , PSD 0.04	2 LLCR: Δ 15 m Ω maximum	
Mechanical Shock	EIA-364-27 100 G, 6 milliseconds, sawtooth wave, 11.3 fps, 3 shocks/direction, 3 axis (18 total shocks)	Visual Inspection: No Damage LLCR: Δ 15 mΩ maximum Event Detection: No interruption > 50 Nanoseconds	Pass
Normal Force	EIA-364-04	30 grams minimum for gold interface	



3.7 Environmental:

ITEM	TEST CONDITION	REQUIREMENT	STATUS
Thermal Shock	EIA-364-32 Thermal Cycles: 100 (30 minute dwell) Hot Temp: 85°C Cold Temp: -55°C Hot/Cold Transition: Immediate	Visual Inspection: No Damageycles: 100 (30 minute dwell) 85° C 52° C 12° C	
Thermal Aging (Temp Life)	EIA-364-17 Test Condition 4 @ 105°C Condition B for 250 hours	Visual Inspection: No Damage LLCR: Δ 15 mΩ DWV: 525 VAC IR: >50,000 MΩ	Pass
Cyclic Humidity	HumidityEIA-364-31 Test Temp: 25°C to 65°C Relative Humidity: 90 to 95% Test Duration: 240 hoursVisual Inspection: No Damage LLCR: Δ 15 mΩ DWV: 525 VAC IR: >50,000 MΩ		Pass
Gas Tight	EIA-364-36 Gas Exposure: Nitric Acid Vapor Duration: 60 min. Drying Temp.: 50°C +/- 3°C Measurements: Within 1 hour of Exposure	LLCR: Δ 15 mΩ	Pass

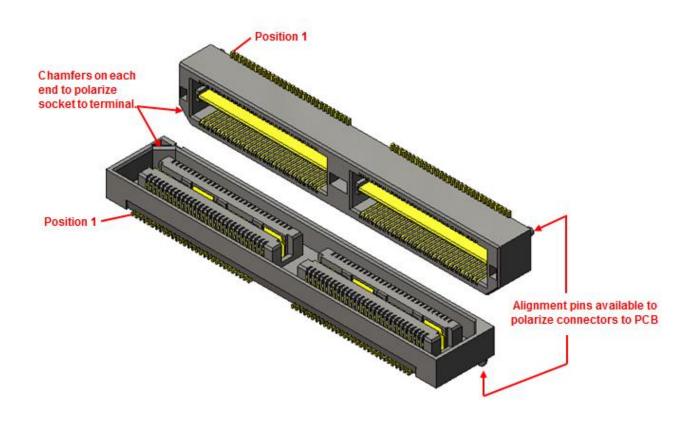


4.0 MATED SYSTEM

4.1 Mated Views:

Mated view information can be found at link below: http://suddendocs.samtec.com/prints/qxh%20mated%20document-mkt.pdf

5.0 POLARIZING FEATURES



6.0 HIGH SPEED PERFORMANCE

6.1 Based on a 3 dB insertion loss

Stack Height	Single-Ended Signaling	Differential Pair Signaling
5mm	9.5 GHz / 19 Gbps	10.5 GHz / 21 Gbps

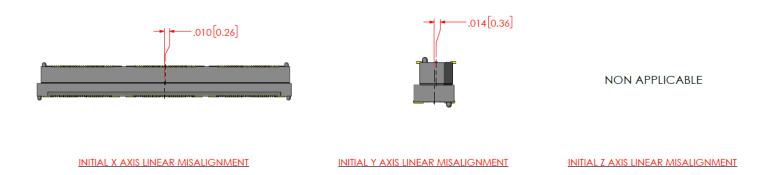
6.2 System Impedance: 50 ohm for single-ended and 100 ohm for differential pair



7.0 PROCESSING RECOMMENDATIONS

7.1 Mating Alignment Requirements:

7.1.1 The Allowable initial linear misalignment.



7.1.2 Allowable final linear misalignment.

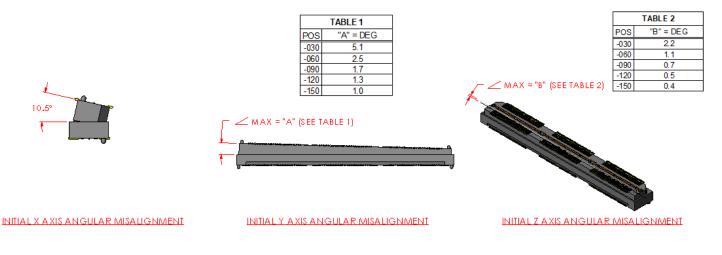
	TABLE	3	1
	OPTION	"C"	1
	QTH-DV to QSH-DV	.001 [0.03]]
	QTH-DV to QSH-RA	.001 [0.03]	
	QTH-RA to QSH-DV	.002 [0.05]	
	QTH-RA to QSH-RA	.002 [0.05]	
		— "C" (SEE TAE	ABLE 3) SEE MATED VIEWS DOCUMENT
FINAL X AXIS LINEAR MISALIGNMENT	<u>FINAL Y AXIS LINEA</u>	<u>r misaligna</u>	MENT FINALZ AXIS LINEAR MISALIGNM

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7.2 Mating Angle Requirements:

7.2.1 Allowable initial angular misalignment



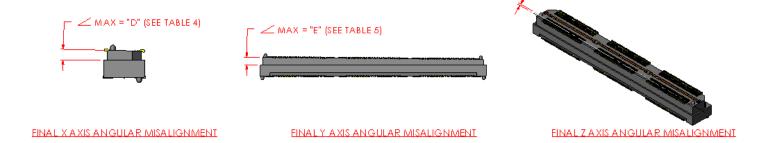
7.2.2 Allowable final angular misalignment

TABL	TABLE 4				
OPTION "D"= DEGREES					
QTH-DV to QSH-DV	1.3				
QTH-DV to QSH-RA	1.3				
QTH-RA to QSH-DV	4.0				
QTH-RA to QSH-RA	4.0				

	TABLE 5				
POS	"E" = DEGREES				
-030	0.52				
-060	0.26				
-090	0.17				
-120	0.13				
-150	0.10				

TABLE 6						
POS	"F" = DEG QTH-DV to QSH-DV	"F" = DEG QTH-DV to QSH-RA		"F" = DEG QTH-DV to QSH-RA		
-030	0.43	0.27	0.65	0.65		
-060	0.21	0.14	0.30	0.30		
-090	0.14	0.09	0.19	0.19		
-120	0.11	N/A	N/A	N/A		
-150	0.09	N/A	N/A	N/A		

📈 MAX = "F" (SEE TABLE 6)



7.3 Multiple Connector Applications: Not recommended for application in which multiple connectors are mated to a single daughtercard. For more information, please contact <u>IPG@samtec.com</u>.



7.4 Due to variances in equipment, solder pastes and applications (board design, component density, etc.), Samtec does not specify a recommended reflow profile for our connectors. The processing parameters provided by the solder paste manufacturer should be employed and can usually be found on their website.

All of Samtec's surface mount components are lead free reflow compatible and compliant with the profile parameters detailed in IPC/JEDEC J-STD-020 which requires that components be capable of withstanding a peak temperature of 260°C as well as 30 seconds above 255°C.

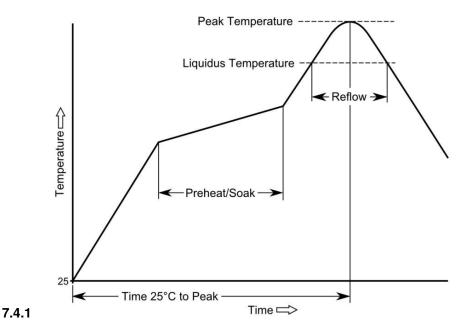
Samtec Recommended Temperature Profile Ranges (SMT)

Preheat/Soak	Max Ramp Up	Reflow Time	Peak	Time within 5°C	Max Ramp	Time 25°C to
(100°C-150°C)	Rate	(above 183°C)	Temp	of 235°C	Down Rate	Peak Temp
60-120 sec.	3°C/s max.	40-150 sec.	235°C	20 sec. max.	6°C/s max.	

Sn-Pb Eutectic Assembly

Pb-Free Assembly

Preheat/Soak	Max Ramp Up	Reflow Time	Peak	Time within 5°C	Max Ramp	Time 25°C to
(150°C-200°C)	Rate	(above 217°C)	Temp	of 260°C	Down Rate	Peak Temp
60-120 sec.	3°C/s max.	40-150 sec.	260°C	30 sec. max.	6°C/s max.	8 min. max.



These guidelines should not be considered design requirements for all applications. Samtec recommends testing interconnects on your boards in your process to guarantee optimum results.

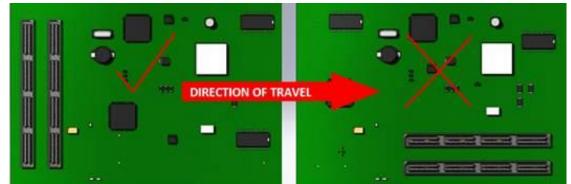
7.5 Maximum Reflow Passes: The parts can withstand three reflow passes at a maximum component temperature of 260°C.



- 7.6 Stencil Thickness: The recommended stencil thickness is .006" (0,15 mm).
- 7.7 Placement: Machine placement of the parts is recommended.
- **7.8 Reflow Environment:** Samtec recommends the use of a low level oxygen environment (typically achieved through Nitrogen gas infusion) in the reflow process to improve solderability.
- **7.9 Rework Guidelines:** Samtec recommends following these rework guidelines as needed: <u>QXX/BXX Connector</u> Rework Methods
- **7.10 Hardware:** Board-to-board standoffs are recommended to provide a robust mechanical connection. Samtec offers two different types:
 - **7.10.1** Traditional Standoffs (SO) Rigid design to statically support board-to-board applications. See options here: <u>SO Board Stacking Standoff</u>
 - **7.10.2** Jack Screw Standoffs (JSO) Serve same function as traditional standoffs but unique, nested construction facilitates the mating and unmating process. This is especially helpful for multiple connector applications where the mating and unmating forces increase with the number of connectors used. See options here: JSO Jack Screw Standoffs
- **7.11 Cleaning:** Samtec, Inc. has verified that our connectors may be cleaned in accordance with the solvents and conditions designated in the EIA-364-11 standard.
- **7.12 Inverted Reflow:** For applications of QTH-120-07/-08 components requiring inverted reflow soldering, use of an epoxy adhesive is recommended. For more information on the use of epoxy adhesives, please visit the Processing page on our website or contact Samtec's Interconnect Processing Group at IPG@samtec.com

8.0 DIRECTION OF BOARD TRAVEL THROUGH REFLOW OVEN

8.1 To minimize the potential for connector warpage, Samtec recommends the layout configuration shown below left. This allows the connectors to heat more evenly.



9.0 ADDITIONAL RESOURCES

9.1 For additional mechanical testing or product information, contact our Customer Engineering Support Group at CES@samtec.com



- **9.2** For additional information on high speed performance testing, contact our Signal Integrity Group at <u>SIG@samtec.com</u>
- 9.3 For additional processing information, contact our Interconnect Processing Group at IPG@samtec.com.
- **9.4** For RoHS, REACH or other environmental compliance information, contact our Product Environmental Compliance Group at <u>PEC@samtec.com</u>

USE OF PRODUCT SPECIFICATION SHEET

This Product Specification Sheet ("PSS") is a brief summary of information related to the Product identified. As a summary, it should only be used for the limited purpose of considering the purchase/use of Product. For specific, detailed information, including but not limited to testing and Product footprint, refer to Section 2.0 of this document and the links there provided to test reports and prints. This PSS is the property of Samtec, Inc. ("Samtec") and contains proprietary information of Samtec, our various licensors, or both. Samtec does not grant express or implied rights or license under any patent, copyright, trademark or other proprietary rights and the use of the PSS for building, reverse engineering or replication is strictly prohibited. By using the PSS, the user agrees to not infringe, directly or indirectly, upon any intellectual property rights of Samtec and acknowledges that Samtec, our various licensors, or both own all intellectual property therein. The PSS is presented "AS IS". While Samtec makes every effort to present excellent information, the PSS is only provided as a guideline and does not, therefore, warrant it is without error or defect or that the PSS contains all necessary and/or relevant information about the Product. The user agrees that all access and use of the PSS is at its own risk. **NO WARRANTIES EXPRESSED OR IMPLIED, INCLUDING ANY WARRANTY OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR OF ANY KIND WHATSOEVER ARE PROVIDED.**